## Determination of the Physical Integrity of Ethernet Cables by Obtaining their Transmission Line Parameters from Measured Impedance Profiles

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*Abstract* – A method of determining the physical integrity of Ethernet cables by obtaining their transmission line parameters (resistance, inductance, capacitance, and conductance) from their measured impedance profiles are presented. The transmission line parameters were extracted across the cable lengths rather than frequencies used in most research. The method can be used to examine the physical integrity of Ethernet cables before their deployment. The study of the physical integrity of Ethernet cables is very important because, in typical installations, cables can be manipulated in the form of repeated coiling and uncoiling. The installation handling stress can adversely affect the signal integrity especially if they are substandard Ethernet cables. In this paper, four Ethernet cables were subjected to three coiling and uncoiling tests to represent installation handling stress. The impedance profiles of the four cables across their lengths were measured for the three handling stress test conducted. The computation of the transmission line parameters of the Ethernet cables using measured impedance profiles was implemented with the aid of Matrix Laboratory (MATLAB). The outcome of the research showed that the method presented will be very useful to cable installers and contractors in making objective decisions in the choice of cables for deployment.

*Index Terms* – Ethernet cables, impedance profile, physical integrity, transmission line parameters.

#### I. INTRODUCTION

Ethernet over twisted pair cables has over the years provided a cost-effective solution for network connectivity as it offers low cost, ease of use, and scalability [\[1](#page-4-0)[–3\]](#page-4-1). The use of Ethernet over twisted pair cables can now be found in Internet of things (IoT), industrial and automotive applications [\[4,](#page-5-0) [5\]](#page-5-1). The trend for future Ethernet over twisted pair cables is now towards higher bandwidths on shorter cable lengths [\[6,](#page-5-2) [7\]](#page-5-3).

It has been observed that the way twisted pair cables are packaged and handled during installation could undermine their physical structure especially if they are non-standard compliant and counterfeit [\[8,](#page-5-4) [9\]](#page-5-5). There are also the problems of non-compliant cables due to poor quality control [\[10\]](#page-5-6). The availability of copperclad aluminum cables (CCA) in the market that have been termed unfit for use as communication cables is another problem of great concern to cable engineers and installers [\[11,](#page-5-7) [12\]](#page-5-8).

There is, therefore, the need for cable engineers to examine the physical integrity of selected cables in the market before their deployment to ensure that signal degradation will be minimized after installation. Most of the research in the literature is focused on computing the transmission line parameters across their frequencies [\[13–](#page-5-9)[15\]](#page-5-10). This paper provides a method of examining the physical integrity of the Ethernet cables by obtaining the resistance, inductance, capacitance, and conductance (RLCG) across their lengths from measured impedance profiles using MATLAB. The method presented also enables cable engineers to have a view of where the length of the cable is adversely affected. Four twisted pair cables including a CCA cable were subjected to three times-coiling and stretching tests to study their physical integrity.

### II. MATERIALS AND METHODS A. Cable materials

The cable materials used for the computation of RLCG parameters from the measured impedance profiles are:

- Cable 1: insulating material is polyethylene, conductor material is copper, the diameter of the conductors is 0.57 mm, and the distance between the centers of the conductors is 0.99 mm.
- CCA cable 2: insulating material is polyethylene,

conductor material is copper, cladding material is copper, diameter of the conductors is 0.57 mm, and the distance between the centers of the conductors is 1.03 mm.

- Cable 3: insulating material is polyethylene, conductor material is copper, diameter of the conductors is 0.54 mm, and the distance between the centers of the conductors is 0.96 mm.
- Cable 4: insulating material is polyethylene, conductor material is copper, diameter of the conductors is 0.57 mm, and the distance between the centers of the conductors is 1.01 mm.

#### B. Methodology

The RLCG parameters per unit-length for a single pair of cables will be computed from their measured impedance by using the mathematical expression for the transmission line parameters.

The R, L, G, and C can be calculated as expressed in [\[16\]](#page-5-11) as follows:

The resistance (R) per meter is:

$$
R = \frac{2R_s}{\pi d} \cdot (\Omega/m),\tag{1}
$$

where the surface resistivity  $R_s$  is:

$$
R_s = \sqrt{\frac{\pi f \mu_c}{\sigma_c}}.
$$
 (2)

The inductance per meter is:

$$
L = \frac{\mu}{\pi} In \left[ \left( \frac{D}{d} \right) + \sqrt{\left( \frac{D}{d} \right)^2 - 1} \right] (H/m). \quad (3)
$$

The conductance per meter is:

$$
G = \frac{\pi \sigma}{\ln \left[ \left( \frac{D}{d} \right) + \sqrt{\left( \frac{D}{d} \right)^2 - 1} \right]} (S/m). \tag{4}
$$

The capacitance per meter is:

$$
C = \frac{\pi \varepsilon}{\ln \left[ \left( \frac{D}{d} \right) + \sqrt{\left( \frac{D}{d} \right)^2 - 1} \right]} (\mathbf{F/m}), \tag{5}
$$

where D is the distance between the centers of the conductors, d is the diameter of the conductor,  $\mu_c$  is the permeability of the conductor,  $\sigma_c$  is the conductivity of the conductor,  $\sigma$  is the conductivity of the insulating material,  $\varepsilon$  is the effective permittivity of the insulating material,  $\mu$  is the permeability of the insulating material and  $f$ is the frequency in Hz.

The attenuation constant  $(\alpha)$ , which is the real part of the propagation constant  $(\gamma)$ , is expressed in [\[17\]](#page-5-12) as:

<span id="page-1-0"></span>
$$
\alpha = \frac{1}{2} \left( R \sqrt{\frac{C}{L}} + G \sqrt{\frac{L}{C}} \right),\tag{6}
$$

Similarly, the phase constant  $(\beta)$ , which is the imaginary part of the propagation constant  $(\gamma)$ , is given in [\[17\]](#page-5-12) as:

<span id="page-1-1"></span>
$$
\beta = \omega \sqrt{LC}.\tag{7}
$$

Therefore, the propagation constant  $(\gamma)$  from equations [\(6\)](#page-1-0) and [\(7\)](#page-1-1) is:

$$
\gamma = \frac{1}{2} \left( R \sqrt{\frac{C}{L}} + G \sqrt{\frac{L}{C}} \right) + j\omega \sqrt{LC}, \qquad (8)
$$

The RLCG parameters for a single pair of the cable can now be computed from the cable impedance given in [\[15,](#page-5-10) [18\]](#page-5-13) as:

$$
R = Re\left(\gamma Z_o\right)(\Omega/m),\tag{9}
$$

$$
L = Im\frac{(\gamma Z_o)}{\omega} (H/m), \qquad (10)
$$

$$
C = Im \frac{\left(\frac{\gamma}{Z_o}\right)}{\omega} (F/m), \qquad (11)
$$

$$
G = Re\left(\frac{\gamma}{Z_o}\right)(S/m),\tag{12}
$$

where  $Z<sub>o</sub>$  is the twisted pair cable impedance measurements in ohms due to handling stress test.

#### C. Measurement procedure

Four category 6 unshielded twisted pair (UTP) cables were selected for the impedance profile measurements. The cables selected are tagged Cable 1, Cable 2 (CCA), Cable 3, and Cable 4. The DSX-5000 cable analyzer that can handle testing and certification of category 6 cables was used for the impedance measurement [\[19,](#page-5-14) [20\]](#page-5-15). The UTP cables were tested in accordance with the International Standard ISO/IEC 11801 Class E, which can measure up to 250 MHz. The cable analyzer contains two main modes: "main" and the "renote", which have openings to connect them to standard link adapters [\[20\]](#page-5-15). These main and remote modes are connected through patch cord plugs to the cable under examination [\[20\]](#page-5-15). The DSX-5000 analyzer has a High-Definition Time Domain Reflectometry (HDTDR) embedded in it to measure the impedance profiles across the decaded in it to measure the impedance promes across the length of the cables. The schematic diagram of the cable analyzer set up for measurement is shown in Fig. [1.](#page-1-2) shown in Fig. 1.



<span id="page-1-2"></span>surement setup. Note: A1 is the main mode link interface adapter with the patch cord plug,  $A2$  is the remote link interface adapter with the patch cord plug, and temper interface adapter with the patch cord plug, andB is the<br>UTP coble under test UTP cable under test. Fig. 1. The schematic diagram of the cable analyzer mea-<br>surement setup. Note: A1 is the main mode link interface<br>adapter with the patch cord plug, A2 is the remote link<br>interface adapter with the patch cord plug, andB is

 Our research used the standard T568 pin connection Our research used the standard T568 pin connection with the registered (RJ45) connector for the four pairs of each cable to be measured. The four cables under the impedance profiles test consist of four twisted pairs each of which was labeled as orange, blue, green, and brown.

The coiling of the cables had a diameter of 30 cm so as to exceed the maximum bending allowed. The three test measurements taken are as follows:

- Measurement 1: cable used to form coils and stretched before test
- Measurement 2: cable in measurement 1 used to form coils and stretched before test
- Measurement 3: cable in measurement 2 used to form coils and stretched before test

#### III. MEASURED IMPEDANCE PROFILES

The measured impedance profiles across the lengths of the four cables at 250 MHz using the third coiling and uncoiling test results is shown in Figs. [2–](#page-2-0)[4](#page-2-1) for the orange, green and blue pairs. A view of Figs. [2](#page-2-0)[–4](#page-2-1) show that the CCA cable 2 is the most affected by the installation handling test as it gave a distinct variation in impedance profiles for all pairs.



<span id="page-2-0"></span>Fig. 2. Impedance profile of the orange pair.



Fig. 3. Impedance profile of the green pair.



<span id="page-2-1"></span>Fig. 4. Impedance profile of the blue pair.

## IV. RESULT OF THE RLCG PARAMETERS EXTRACTED FROM MEASUREMENT

The results of the RLCG parameters across the lengths of the four cables at 250 MHz using the third coiling and uncoiling measured impedance results are shown from Figs. [5–](#page-2-2)[16](#page-4-2) for the orange, green, and blue



<span id="page-2-2"></span>Fig. 5. Resistance comparison of the four cables using the orange pair.



Fig. 6. Inductance comparison of the four cables using the orange pair.



Fig. 7. Capacitance comparison of the four cables using the orange pair.



Fig. 8. Conductance comparison of the four cables using the orange pair.



Fig. 9. Resistance comparison of the four cables using the green pair.

pairs. Figures [5–](#page-2-2)[16](#page-4-2) show that CCA Cable 2 had a wide margin for resistance and conductance in comparison to the other three cables, indicating that it is the most affected by the installation handling test.



Fig. 10. Inductance comparison of the four cables using the green pair.



Fig. 11. Capacitance comparison of the four cables using the green pair.



Fig. 12. Conductance comparison of the four cables using the green pair.

### V. DISCUSSION OF THE RESILIENCE OF THE CABLES

The graphical results in Figs. [5](#page-2-2)[–16](#page-4-2) show that the CCA cable 2 gave a distinct wide margin in the resistance and conductance across the length than the three



Fig. 13. Resistance comparison of the four cables using the blue pair.



Fig. 14. Inductance comparison of the four cables using the blue pair.



Fig. 15. Capacitance comparison of the four cables using the blue pair.

other cables for all pairs. This indicates that the CCA cable 2 gave the worst resilience after the third handling stress test than the three other cables. This confirms what is stated in literature that it is a bad communication cable. On the other hand, a view of the plots in Figs. [5](#page-2-2)[–16](#page-4-2) show that cable 4 gave the least changes in the RLCG



<span id="page-4-2"></span>Fig. 16. Conductance comparison of the four cables using the blue pair.

parameters in comparison to the other three cables. This indicates that cable 4 gave the best resilience after the third test. The results of the test show that cable 4 has the best physical integrity as it is the least affected by the coiling and uncoiling tests.

## VI. CONCLUSIONS

This paper has provided a method that can be used to determine the physical integrity of Ethernet cables by obtaining the RLCG parameters from their measured impedance profiles using MATLAB. The research was the determination of the transmission line parameters across their lengths to have a better view of the cable behavior. Four Ethernet cables were examined including a CCA cable termed unfit for use as a communication cable. The results of the study indicate that the CCA cable provided the worst resilience to the handling stress tests as it showed the highest changes in the RLCG parameters across the length. Cable 4 on the other hand, gave the best resilience to the handling stress tests as it showed the least changes in the RLGC parameters across the length. The method provided will be of help to cable engineers, installers, and contractors when selecting cables for deployment to minimize problems that may arise after installation.

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